

**Search Notes**

Application/Control No.

10/791,214

Examiner

John A. Tweel, Jr.

Applicant(s)/Patent under  
Reexamination

CHAHROUR ET AL.

Art Unit

2636

**SEARCHED**

Class	Subclass	Date	Examiner
340	584	10/25/2005	JAT
	577	10/25/2005	JAT
	578	10/25/2005	JAT
	584	10/25/2005	JAT
	587	10/25/2005	JAT
	589	10/25/2005	JAT
	655	10/25/2005	JAT

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR